

Features

- 3rd generation SiC MOSFET technology
- Optimized package with separate driver source pin
- High blocking voltage with low on-resistance
- High-speed switching with low capacitances
- Fast intrinsic diode with low reverse recovery (Q,,)
- Halogen free, RoHS compliant

Benefits

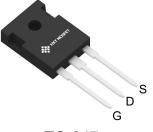
- Reduce switching losses and minimize gate ringing
- Higher system efficiency
- Reduce cooling requirements
- Increase power density
- Increase system switching frequency

Applications

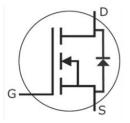
- Renewable energy
- EV battery chargers
- High voltage DC/DC converters
- Switch Mode Power Supplies











Maximum Ratings (T_c = 25 °C unless otherwise specified)

Parameter	Symbol	Value	Unit
Drain-source voltage	V _{DS}	1200	V
Continuous drain current			
T _C = 25°C	I _D	40	Α
T _C = 100°C		28	
Pulsed drain current ($T_C = 25^{\circ}C$, t_p limited by T_{jmax})	I _{D pulse}	80	Α
Avalanche energy, single pulse (L=10mH)	E _{AS}	600	mJ
Gate-Source voltage	V _{GS}	-4/+18	V
Gate-Source voltage (Absolute maximum values)	V_{GSmax}	-8/+22	V
Power dissipation (T _C = 25°C)	P _{tot}	214	W
Operating junction and storage temperature	T_{j} , T_{stg}	-55+175	°C

•Example of acceptable V_{GS} waveform





Thermal Resistance

Parameter	Symbol	Value	Unit
Thermal resistance, junction – case. Max	R _{thJC}	0.70	°C/W
Thermal resistance, junction – ambient. Max	R_{thJA}	40	C/VV

Electrical Characteristic (at Tj = 25 °C, unless otherwise specified)

Parameter	Sumah al	Value			I I mid	Took Condition	
Parameter	Symbol	min.	typ.	max.	Unit	Test Condition	
Static Characteristic							
Drain-source breakdown voltage	BV _{DSS}	1200	-	-	V	V _{GS} =0V, I _D =100uA	
Gate threshold voltage	V _{GS(th)}	2.3	2.8	3.6	V	$V_{DS}=V_{GS}$, $I_{D}=5mA$	
Zero gate voltage drain current	I _{DSS}	-	1 5	10 -	μА	V_{DS} =1200V, V_{GS} =0V T_{C} =25°C T_{C} =175°C	
Gate-source leakage current	I _{GSS}	-		100	nA	V _{GS} =18V,V _{DS} =0V	
Drain-source on-state resistance	R _{DS(on)}	-	60 120	75 -	mΩ	V_{GS} =18V, I_{D} =20A, T_{J} =25°C T_{J} =175°C	
Transconductance	g _{fs}	-	10	-	S	V _{DS} =20V,I _D =20A	

Dynamic Characteristic

Input Capacitance	C _{iss}	-	940	-	pF	V _{DS} = 1000V	
Output Capacitance	C _{oss}	-	59	-		$V_{GS} = 0V$ $T_{J} = 25^{\circ}C$ $V_{AC} = 25mV$ $f = 1MHz$ $V_{DS} = 800V$ $V_{GS} = -4/18V$ $I_{D} = 20A$	
Reverse Transfer Capacitance	C _{rss}	-	4.1	-			
Gate Total Charge	Q_{G}	-	42	-			
Gate-Source charge	Q_{gs}	-	8	-	nC		
Gate-Drain charge	Q_{gd}	-	20	-			
Turn-On Switching Energy	E _{ON}	-	330	-	μJ	$V_{DD} = 800V$ $V_{GS} = -4/+15V$ $I_{D} = 20A$ $R_{G} = 0\Omega$ $L = 120uH$	
Turn-Off Switching Energy	E _{OFF}	-	51	-			
Turn-on delay time	t _{d(on)}	-	21	-			
Rise time	t _r	-	23	-			
Turn-off delay time	t _{d(off)}	-	16	-			
Fall time	t _f	-	19	-			
Gate resistance	R _G	-	1.7	-	Ω	V _{AC} = 25mV, f=1MHz	



Body Diode Characteristic

Parameter	Symbol	Value			Unit	Test Condition	
Farameter	Syllibol	min.	typ.	max.	Unit	rest Condition	
Rody Diodo Forward Voltago	W		4.3		· V	V _{GS} =-4V,I _{SD} =10A, T _J =25°C	
Body Diode Forward Voltage	V _{SD}		3.8			V _{GS} =-4V,I _{SD} =10A, T _J =175°C	
Body Diode Reverse Recovery Time	t _{rr}	-	43	-	ns	$V_R = 800V, V_{GS} = -4V$ $I_D = 20A$	
Body Diode Reverse Recovery Charge	Q_{rr}	-	413	-	nC	di/dt = 700A/µS T _J = 150°C	

Typical Performance Characteristics

Fig 1. Output Characteristic (T_J=-40°C)

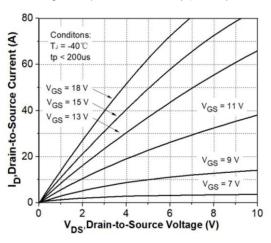


Fig 3. Output Characteristic (T_J=175℃)

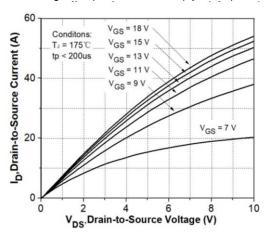


Fig 2. Output Characteristic (T_J=25℃)

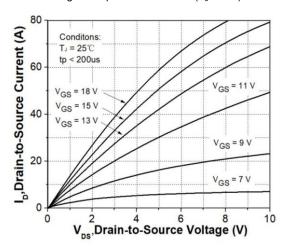
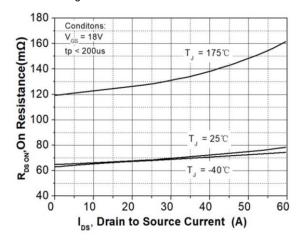


Fig 4: Rdson Vs Ids Characteristic





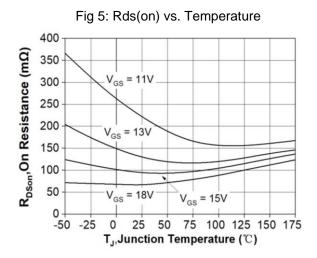


Fig 7: Body-diode Characteristic (T_J=-40°C)

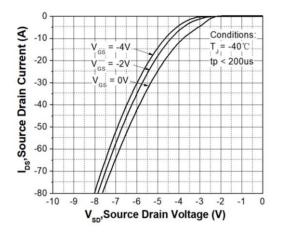


Fig 9: Body-diode Characteristic (T_J=175℃)

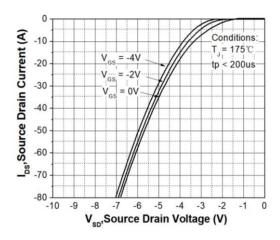


Fig 6: Transfer Characteristic

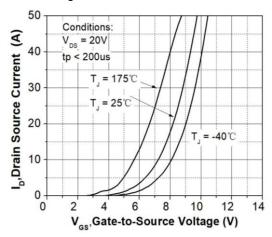


Fig 8: Body-diode Characteristic (T_J=25℃)

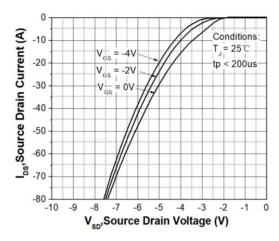
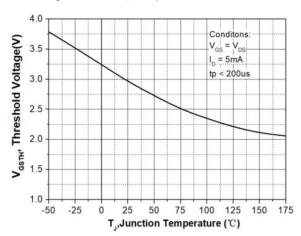
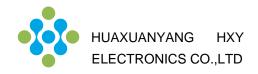


Fig 10: V_{TH} Vs T_J Temperature Characteristic





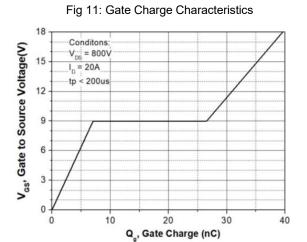


Fig 13: 3rd Quadrant Characteristic(T_J=25℃)

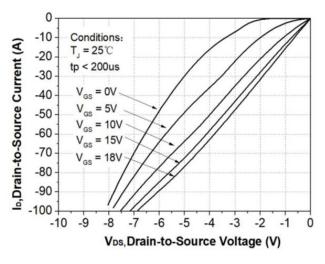


Fig 15: Capacitance Characteristic

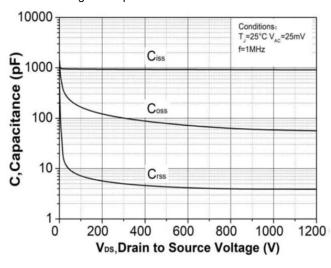


Fig 12: 3rd Quadrant Characteristic(T_J=-40°C)

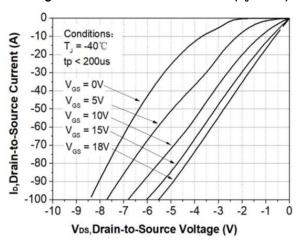


Fig 14: 3rd Quadrant Characteristic(T J=175℃)

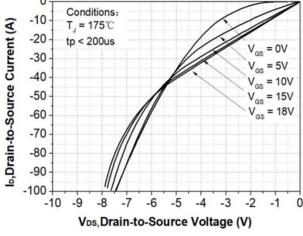
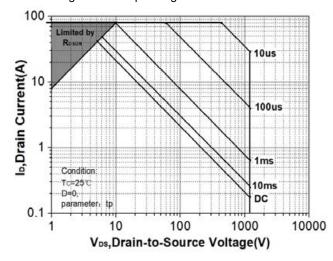
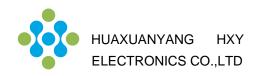


Fig 16: Safe Operating Area





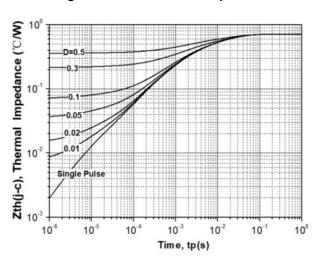


Fig 17: Transient Thermal Impedance

Test Circuit & Waveform

Figure A. Definition of switching times

V_{DS} 90%

V_{GS} 10%

V_{GS} t_{d(on)} t_r t_{on} t_{off} t_{off}

Figure B. Dynamic test circuit

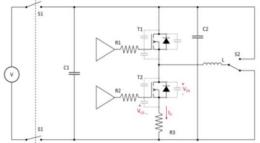


Figure C. Definition of body diodeswitching characteristics

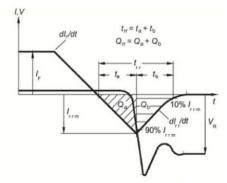
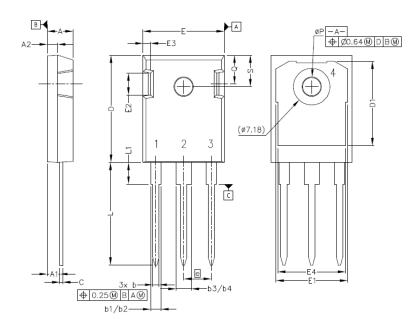


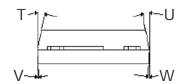
Figure C. Definition of diode switching characteristics



Package Dimensions

Package TO-247

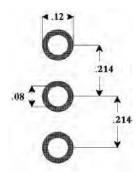




Pinout Information:

- Pin 1 = Gate
- Pin 2, 4 = Drain
- Pin 3 = Source

Recommended Solder Pad Layout



TO-247

B00	Inch	ies	Millimeters		
POS	Min	Max	Min	Max	
А	.190	.205	4.83	5.21	
A1	.090	.100	2.29	2.54	
A2	.075	.085	1.91	2.16	
b	.042	.052	1.07	1.33	
b1	.075	.095	1.91	2.41	
b2	.075	.085	1.91	2.16	
b3	.113	.133	2.87	3.38	
b4	.113	.123	2.87	3.13	
С	.022	.027	0.55	0.68	
D	.819	.831	20.80	21.10	
D1	.640	.695	16.25	17.65	
D2	.037	.049	0.95	1.25	
E	.620	.635	15.75	16.13	
E1	.516	.557	13.10	14.15	
E2	.145	.201	3.68	5.10	
E3	.039	.075	1.00	1.90	
E4	.487	.529	12.38 13.43		
е	.214	BSC	5.44 BSC		
N	3	3	3		
L	.780	.800	19.81	20.32	
L1	.161	.173	4.10	4.40	
ØP	.138	.144	3.51	3.65	
Q	.216	.236	5.49	6.00	
S	.238	.248	6.04	6.30	
Т	9°	11°	9°	11°	
U	9°	11°	9°	11°	
V	2°	8°	2° 8°		
W	2°	8°	2° 8°		



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